

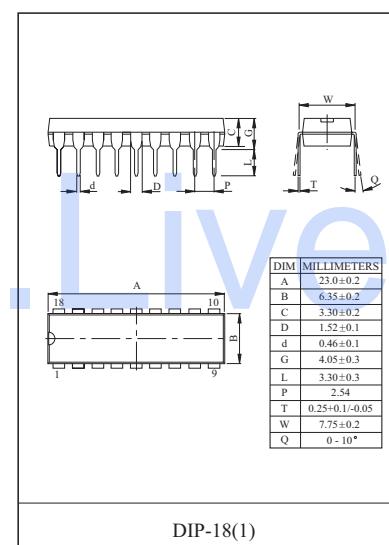
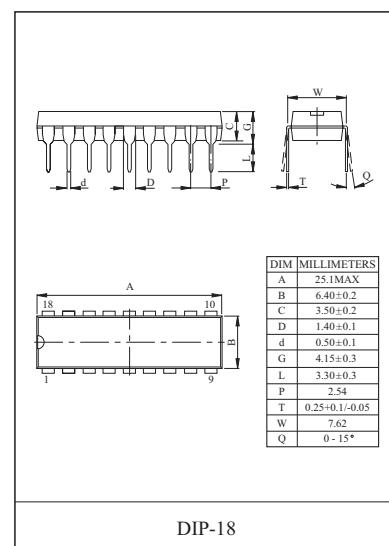
8CH HIGH-VOLTAGE SOURCE DRIVER

The KID65783AP/AF is comprised of eight source current transistor array. This driver is specifically designed for fluorescent display applications. Applications include relay, hammer and lamp drivers.

FEATURES

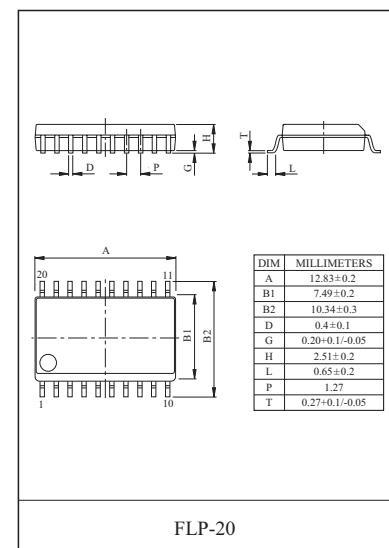
- High Output Voltage : $V_{CC}=50V$ (Min.).
- Output Current (Single Output) $I_{OUT} : -500mA$ (Min.).
- Output Clamp Diodes.
- Single Supply Voltage.
- Input Compatible With Various Types of Logic.
- Package Type-AP : DIP-18pin, DIP-18(1)Pin
- Package Type AF : FLP-20pin.

TYPE	DESIGNATION
KID65783AP/AF	TTL, 5V CMOS

MAXIMUM RATINGS ($T_a=25^\circ C$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V_{CC}	50	V
Output Current	I_{OUT}	-500	mA/ch
Input Voltage	V_{IN}	15	V
Clamp Diode Reverse Voltage	V_R	50	V
Clamp Diode Forward Current	I_F	500	mA
Power Dissipation	P_D (Note)	1.47	W
AF		0.96	
Operating Temperature	T_{opr}	-40 85	
Storage Temperature	T_{stg}	-55 150	

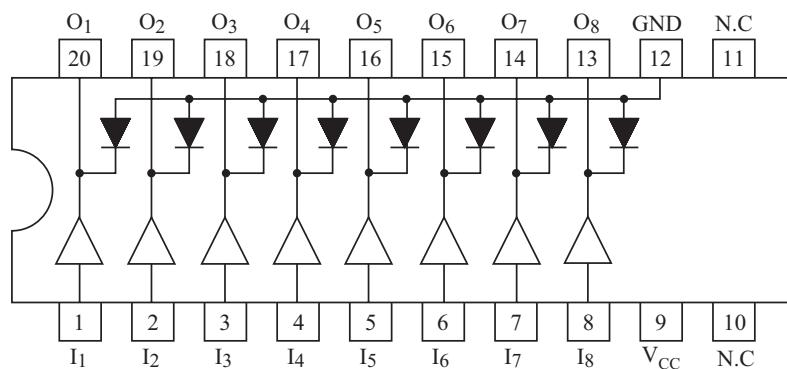
Note) Delated above 25 °C in the proportion of 11.7W/ °C (AP Type), 7.7W/ °C (AF Type).



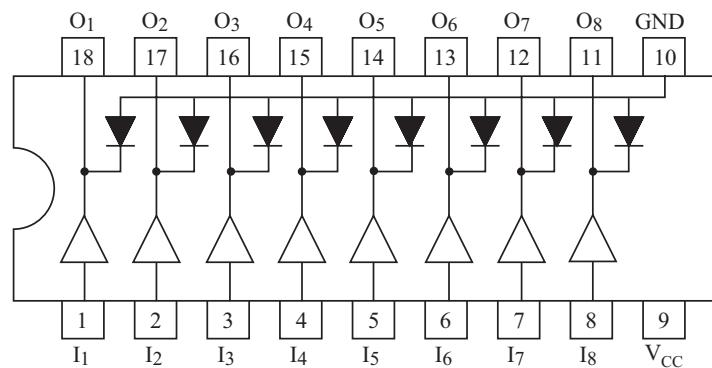
KID65783AP/AF

PIN CONNECTION (TOP VIEW)

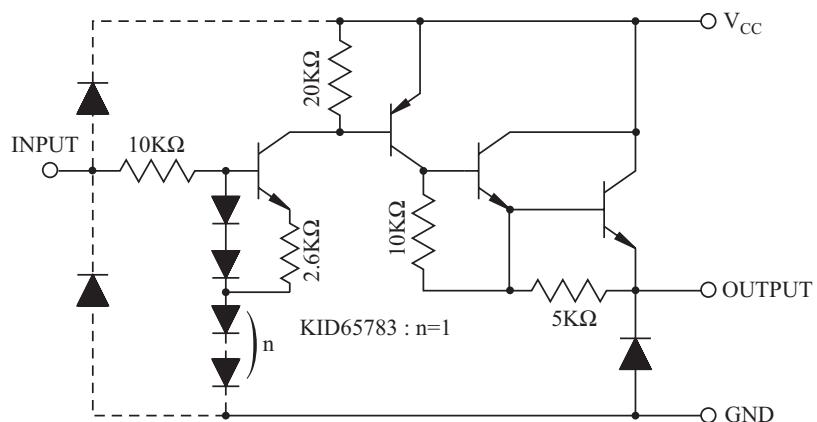
AF-TYPE (FLP-20 package)



AP-TYPE (DIP-18 package)



SCHEMATICS (EACH DRIVER)



(Note) The input and output parasitic diodes
cannot be used as clamp diodes.

KID65783AP/AF

RECOMMENDED OPERATING CONDITIONS (Ta=-40 ~ 85 °C)

CHARACTERISTIC		SYMBOL	TEST CONDITION		MIN.	TYP.	MAX.	UNIT		
Supply Voltage		V _{CC}	-		-	-	50	V		
Output Current	AP	I _{OUT}	Ta=85 Tj=120 Tpw=25mS	Duty=10% 8 Circuits	-	-	-260	mA/ch		
				Duty=50% 8 Circuits	-	-	-59			
	AF			Duty=10% 8 Circuits	-	-	-180			
				Duty=50% 8 Circuits	-	-	-38			
Input Voltage		V _{IN}	-		-	-	12	V		
Input Voltage	Output ON	V _{IN(ON)}	-		2.0	5.0	15	V		
	Output OFF	V _{IN(OFF)}	-		0	-	0.8			
Clamp Diode Reverse Voltage	AP	V _R	-	-	-	-	50	V		
	AF				-	-	35			
Clamp Diode Forward Current		I _F	-		-	-	400	mA		
Power Dissipation	AP	P _D	-	-	-	-	0.52	W		
	AF				-	-	0.35			

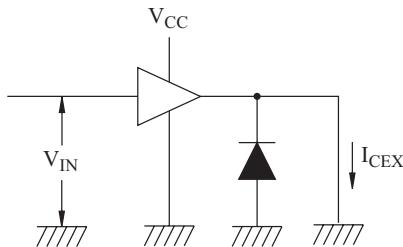
ELECTRICAL CHARACTERISTICS (Ta=25 °C)

CHARACTERISTIC		SYMBOL	TEST CIRCUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Output Leakage Current		I _{CEx}	1	V _{CC} =V _{CC MAX.} V _{IN} =0.4V Ta=25	-	-	100	µA
Output Saturation Voltage	V _{CE(sat)}		2	V _{IN} =V _{IN(ON)} , I _{OUT} =-350mA	-	-	2.0	V
				V _{IN} =V _{IN(ON)} , I _{OUT} =-225mA	-	-	1.9	
				V _{IN} =V _{IN(ON)} , I _{OUT} =-100mA	-	-	1.8	
Input Current	I _{IN(ON)}		3	V _{IN} =2.4V	-	36	52	µA
				V _{IN} =3.85V	-	180	260	
Input Voltage	V _{IN(ON)}		4	V _{CE} =2.0V, I _{OUT} =-350mA	-	-	2.0	V
				I _{OUT} =-500 µA	0.8	-	-	
Supply Current	I _{CC(ON)}	3		V _{IN} =V _{IN(ON)} , V _{CC} =50V	-	-	2.5	mA/ch
Clamp Diode Reverse Current	I _R	5		V _R =50V	-	-	50	µA
Clamp Diode Forward Voltage	V _F	6		I _F =350mA	-	-	2.0	V
Turn-On Delay	t _{ON}	7		V _{CC} =V _{CC MAX.} R _L =125 C _L =15pF	-	0.15	-	µs
Turn-Off Delay	t _{OFF}				-	1.8	-	

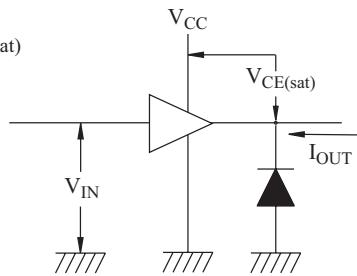
KID65783AP/AF

TEST CIRCUIT

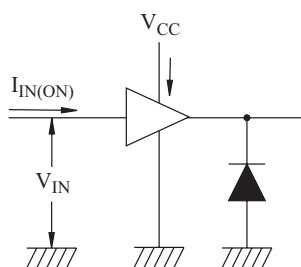
1. I_{CEX}



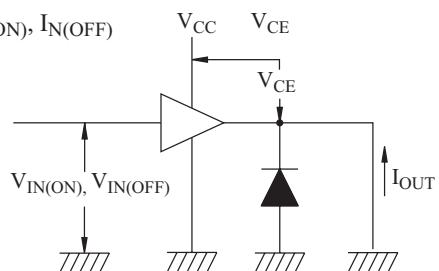
2. $V_{CE(sat)}$



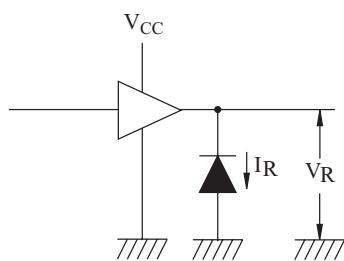
3. $I_{IN(ON)}, I_{CC}$



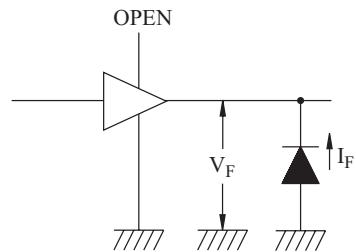
4. $V_{IN(ON)}, I_{N(OFF)}$



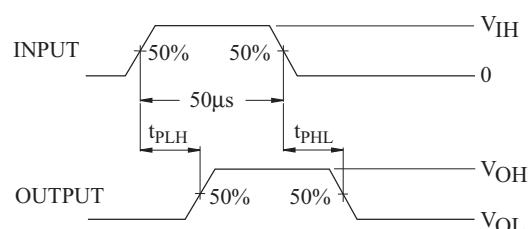
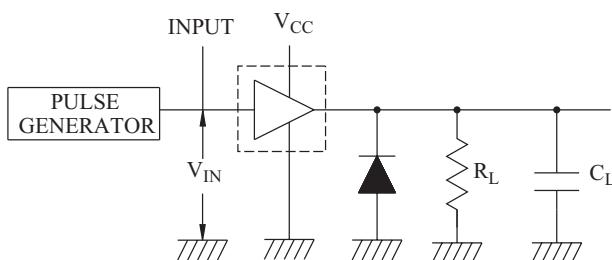
5. I_R



6. V_F



7. t_{ON}, t_{OFF}



(Note 1) Pulse width 50 μ s, duty cycle 10%
Output impedance 50 Ω , $t \leq 5$ ns, $t \leq 10$ ns
(Note 2) C_L includes probe and jig capacitance

KID65783AP/AF

